MENDMENT AND RESPONSE UNDER 37 CFR § 1.111

Serial Number: 10/656,745

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Title: METHOD AND APPARATUS FOR IMPROVED COATING OF A SEMICONDUCTOR WAFER

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IN THE ABSTRACT OF THE DISCLOSURE

Please amend the Abstract as follows:

Disclosed is a A method and apparatus for coating liquid films on to the surface of a wafer substrate by rotation the substrate at a speed sufficient to cause a liquid, through centrifugal effect, to flow outwardly toward the perimeter of the surface and form a substantially uniform thickness liquid coating thereon, and starting from one edge at the central region of the wafer surface and moving radially outward therefrom in a single direction, spraying a fine mist of the liquid to the surface of the wafer.